

Features

High Voltage Operation: V_{DS}=50V
 High Power: 54.0dBm (typ.) @ Psat

· Proven Reliability

Description

Sumitomo Electric's GaN-HEMT offers high efficiency, ease of matching, greater consistency and broad bandwidth for high power L-band amplifiers with 50V operation, and gives you higher gain. This new product is ideally suited for use from 2.65GHz W-CDMA & LTE design requirements as it offers high gain, long term reliability and ease of use.



ABSOLUTE MAXIMUM RATINGS (Case Temperature Tc=25deg.C)

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Item	Symbol	Condition	Rating	Unit		
Operating-Voltage	V_{DS}		55	V		
Drain-Source Voltage	V _{DS}	V _{GS} =-8V	160	V		
Gate-Source Voltage	V_{GS}		-15	V		
Total Power Dissipation	P _t		160.7	W		
Storage Temperature	T _{stg}		-65 to +175	deg.C		
Channel Temperature	T _{ch}		250	deg.C		

RECOMMENDED OPERATING CONDITION

Item	Symbol	Condition	Limit	Unit
DC Input Voltage	V_{DS}		<u><</u> 55	V
Forward Gate Current	${ m I}_{\sf GF}$	R _G =5 ohm	<u><</u> 189	mA
Reverse Gate Current	I_{GR}	R _G =5 ohm	<u>></u> -6.9	mA
Channel Temperature	T_{ch}		<u><</u> 200	deg.C
Average Output Power	P _{ave} .		<u><</u> 51.0	dBm

ELECTRICAL CHARACTERISTICS (Case Temperature T_c=25deg.C)

Item	Symbol Condition	Limit			Unit	
Item	Syllibol	Condition	Min.	Тур.	Max.	Oilit
Pinch-Off Voltage	V_p	V_{DS} =50V I_{DS} =48mA	-4.0	-	-2.0	V
Saturated Power	Psat *1	$V_{DS}=50V$	53.0	54.0	-	dBm
Drain Eficiency at Psat	DE *1	$I_{DS(DC)}$ =0mA f=2.65GHz	50	57	-	%
Power Gain	Gp *2	$I_{DS(DC)}$ =800mA	14.0	15.0	-	dB
Thermal Resistance	R _{th}	Channel to Case at 105W P _{DC}	_	1.2	1.4	deg.C/W

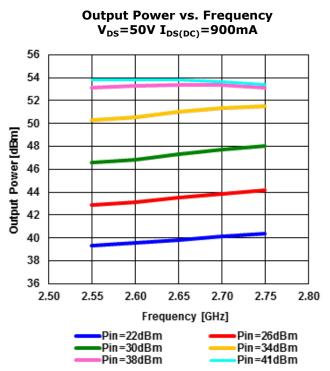
^{*1 :} Pin=41dBm 10%-duty RF pulse (DC supply constant)

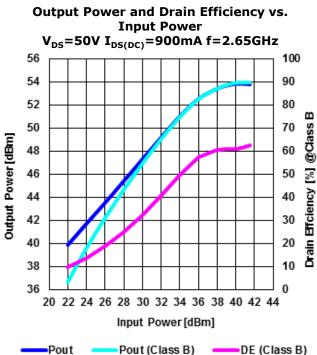
^{*2:} Pout=46dBm, CW modulation Signal (W-CDMA)

RoHS Compliance	YES



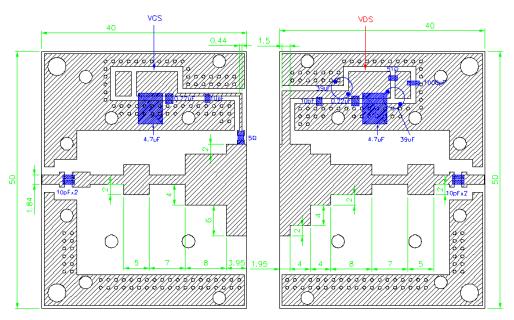
RF characteristics @ f=2.65GHz fine tuned





Pulse Signal (10%-duty, DC : constant)

Test Fixture

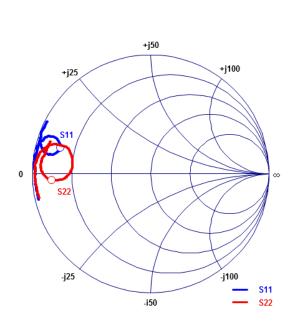


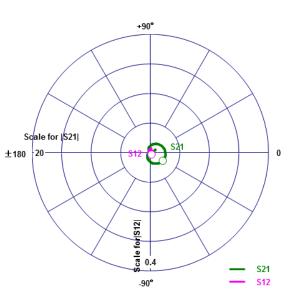
h=0.8mm =r=3.5 Cu=18um Unit:mm



- Reference DATA -

S-Parameters $@V_{DS}=50V$, $I_{DS(DC)}=900mA$, f=0.5 to 4.5GHz ZI=Zs=50 ohm Marker: 2.65GHz

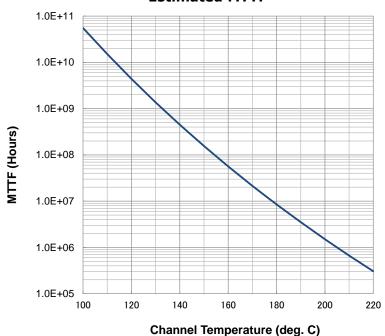




Freq.	S1	.1	S	21	s	12	S	22
GHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
0.5	0.97	-167.18	0.99	30.19	0.001	-14.25	0.97	-167.97
0.6	0.98	-174.57	0.60	21.99	0.001	24.29	0.97	-174.67
0.7	0.98	178.51	0.35	17.54	0.001	29.79	0.98	178.80
8.0	0.98	177.49	0.19	28.07	0.001	80.22	0.98	177.20
0.9	0.98	176.31	0.10	65.74	0.002	78.01	0.98	175.66
1.0	0.98	175.43	0.13	113.20	0.002	82.62	0.98	174.56
1.1	0.99	174.72	0.21	129.04	0.002	79.97	0.97	172.94
1.2	0.98	173.76	0.28	132.07	0.003	78.74	0.97	171.50
1.3	0.98	172.47	0.37	130.37	0.004	83.15	0.96	170.15
1.4	0.99	171.72	0.46	126.65	0.004	76.30	0.95	168.77
1.5	0.99	170.99	0.55	122.48	0.004	74.10	0.93	167.52
1.6	0.98	169.77	0.65	117.38	0.005	76.26	0.91	165.84
1.7	0.98	168.52	0.76	109.75	0.006	70.68	0.89	164.49
1.8	0.99	167.33	0.90	102.39	0.006	67.47	0.87	163.42
1.9	0.99	166.85	1.08	93.75	0.007	63.01	0.84	162.60
2.0	0.98	165.13	1.27	84.01	0.008	57.10	0.80	162.56
2.1	0.97	163.84	1.48	72.32	0.009	46.39	0.74	162.55
2.2	0.95	162.32	1.75	58.49	0.009	36.01	0.70	165.39
2.3	0.93	160.64	2.01	42.93	0.010	23.86	0.67	169.68
2.4	0.90	159.58	2.32	25.35	0.010	6.16	0.67	175.46
2.5	0.85	159.61	2.54	3.83	0.010	-17.43	0.71	-178.46
2.6	0.81	162.02	2.58	-19.61	0.008	-44.08	0.79	-176.17
2.7	0.80	165.61	2.44	-42.93	0.007	-76.74	0.88	-177.72
2.8	0.82	168.00	2.10	-64.21	0.005	-114.53	0.92	178.69
2.9	0.86	169.12	1.75	-81.78	0.005	-154.23	0.93	176.04
3.0	0.90	169.08	1.43	-96.14	0.005	174.09	0.93	173.72
3.1	0.93	168.17	1.18	-108.04	0.005	153.36	0.93	172.07
3.2	0.94	167.11	0.98	-118.10	0.006	135.06	0.92	171.06
3.3	0.95	166.03	0.82	-126.62	0.007	122.49	0.91	170.36
3.4	0.97	164.92	0.70	-134.36	0.007	115.81	0.91	169.93
3.5	0.98	163.84	0.60	-140.76	0.008	110.54	0.91	169.10
3.6	0.98	162.64	0.53	-146.73	0.009	105.35	0.91	168.20
3.7	0.98	161.65	0.46	-152.73	0.009	101.71	0.90	167.94
3.8	0.98	160.45	0.41	-157.75	0.009	97.02	0.90	167.28
3.9	0.99	159.42	0.37	-162.71	0.010	93.63	0.90	166.53
4.0	0.99	158.32	0.33	-167.57	0.010	92.40	0.90	165.70
4.1	0.99	157.57	0.30	-171.91	0.011	90.68	0.90	164.98
4.2	0.98	156.54	0.27	-176.45	0.012	89.87	0.90	164.69
4.3	0.98	155.17	0.25	179.35	0.013	85.26	0.90	163.65
4.4	0.98	154.33	0.23	174.60	0.014	81.85	0.89	162.86
4.5	0.98	153.35	0.21	171.07	0.015	79.42	0.89	162.13



MTTF Calculation
- Estimated MTTF -



Ea=1.6eV Confidence Level=90%

Channel Temp (deg.C)	MTTF (Hours)		
160	5.98 x 10 ⁷		
180	9.02 x 10 ⁶		
200	1.60 x 10 ⁶		

AF=exp[(-Ea/k)(1/T_{stress}-1/T_{use})

 $\mathsf{MTTF}_{\mathsf{use}} = \mathsf{MTTF}_{\mathsf{stress}} * \mathsf{AF}$

Where:

AF: acceleration factor

Ea: activation energy (1.6 eV)

k: Boltzman's constant (8.62 x 10⁻⁵ eV/K)

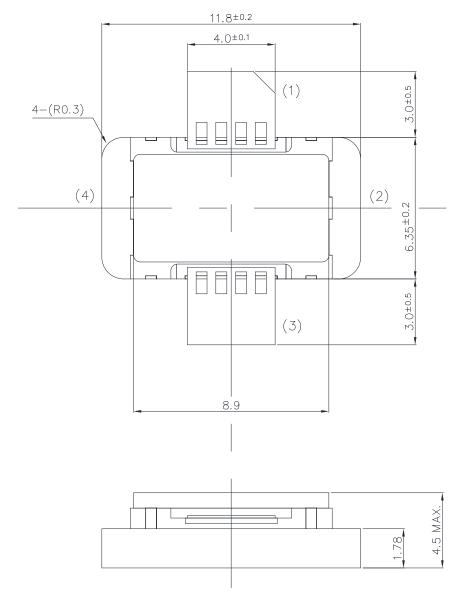
 T_{stress} : stress temperature (K) T_{use} : use temperature (K)

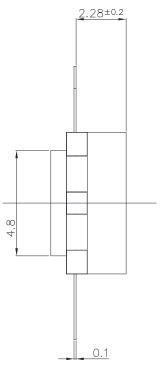
ESD characteristic

Test Methodology	Class
Human Body Model (per JESD22-A114)	1B
Machine Model (per JEIA/ESD22-A115)	А
Device Charged Model (per JESD22-C101)	IV



M1H Package Outline Metal-Ceramic Hermetic Package





- 1. Gate
- 2. Source
- 3. Drain
- 4. Source

Unit: mm

Talerance: ± 0.15



For Safety, Observe the Following Procedures Environmental Management

- Do not put this product into the mouth.
- Do not alter the form of this product into a gas, powder, or liquid through burning, crushing, or chemical processing as these by-products are dangerous to the human body if inhaled, ingested, or swallowed.
- Respect all applicable laws of the country when discarding this product.
 This product must be disposed in accordance with methods specified by applicable hazardous waste procedures.

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